proportional to the above estimated time (t_{tw} and t_0). With the measured $v_{\{111\}}$ and $v_{\{422\}}$ values, the EM-induced void growth rate for the twinmodified Cu grain (l = 5 nm) is calculated to be approximately one order of magnitude lower than that for the twin-free Cu grain. The effect of twin boundaries on slowing down the EM-induced voiding is expected to decrease with an increase of the twin-lamella width (that is, a decrease in the twin density). The twin boundary–induced atomic-migration delay may also decrease with rising temperature because the EM-induced atomic diffusion is a thermally activated process. However, typical integrated circuit devices usually operate at temperatures ~100°C.

We have observed the atomic-scale EM process in twin-modified Cu grains near room temperature with the use of ultrahigh-vacuum and highresolution TEM technique. The EM-induced atomic migration along a twin-modified grain boundary was observed, and the presence of the triple point of a coherent twin boundary meeting a grain boundary was found to retard the EM-induced atomic transport.

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Supporting Online Material

www.sciencemag.org/cgi/content/full/321/5892/1066/DC1 Materials and Methods Fig. S1 Movie S1

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A Stable Silicon(0) Compound with a Si=Si Double Bond

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Dative, or nonoxidative, ligand coordination is common in transition metal complexes; however, this bonding motif is rare in compounds of main group elements in the formal oxidation state of zero. Here, we report that the potassium graphite reduction of the neutral hypervalent silicon-carbene complex L:SiCl₄ {where L: is :C[N(2,6-Prⁱ₂-C₆H₃)CH]₂ and Prⁱ is isopropyl} produces L:(Cl)Si–Si(Cl):L, a carbene-stabilized bis-silylene, and L:Si=Si:L, a carbene-stabilized diatomic silicon molecule with the Si atoms in the formal oxidation state of zero. The Si-Si bond distance of 2.2294 \pm 0.0011 (standard deviation) angstroms in L:Si=Si:L is consistent with a Si=Si double bond. Complementary computational studies confirm the nature of the bonding in L:(Cl)Si–Si(Cl):L and L:Si=Si:L.

Ithough silicon is predominantly associated with semiconductors, integrated circuits, and advanced electronic devices, its structures and bonding motifs intrigue chemists because they are often substantially different from those of silicon's lighter congener carbon. For example, the chemical and physical properties of CO₂ are totally unlike those of SiO₂, and hypervalent species such as [SiF₅]⁻ are unknown for carbon (1). Even though molecules containing C-C multiple bonds are ubiquitous and have been studied for more than two centuries, it was not until 1981 that a disilene, a compound containing a Si-Si double bond (R₂Si=SiR₂, where R is Me₃C₆H₂) was prepared by West et al. (2); a disilyne (RSi≡SiR, where R is an extremely bulky ligand), a compound

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*To whom correspondence should be addressed. E-mail: schleyer@chem.uga.edu (P.v.R.S.); robinson@chem.uga. edu (G.H.R.) containing a Si-Si triple bond (albeit with a decidedly nonlinear, transbent geometry), was ultimately achieved by Sekiguchi *et al.* in 2004 (*3*). In addition to disilenes and disilynes, a number of other interesting stable low-coordinate Si



compounds have been reported (4–7). Regarding the oxidation state of Si in low-coordinate compounds, the central Si atoms in disilenes and disilynes are in the formal oxidation states of two (+2) and one (+1), respectively. It is well known for transition metals to assume the formal oxidation state of zero in organometallic compounds [for example, Ni(CO)₄, (C₆H₆)₂Cr, etc.]; however, the formal oxidation state of zero is rare for main group elements in their compounds (apart from those in Zintl phases) (8, 9).

The study of highly reactive Si(0) intermediates may prove critical in the development of new synthetic strategies in Si chemistry. Such experimental studies, however, require sophisticated instruments and elaborate techniques (10). For example, the diatomic Si₂ molecule, having a triplet ground state ($X^{3}\Sigma_{g}^{-}$), has been studied only in the gas phase and in argon matrices (11). Recently, the CO complex of the Si₂ molecule, OC:Si=Si:CO, was examined with argon matrix isolation absorption infrared spectroscopy and computed to have an unusual transbent structure



Fig. 2. Molecular structures of L:(Cl)Si-Si(Cl):L, (2), and L:Si=Si:L, (3). L: is :C{N(2,6- $Pr_{2}^{i}C_{6}H_{3}$)CH}₂. Thermal ellipsoids represent 30% probability. Hydrogen atoms were omitted for clarity. Selected bond distances (Å) and angles (deg) for (2) are Si(1)-Si(2), 2.393(3); Si(1)-C(1), 1.939(6); Si(1)-Cl(1), 2.161(3); Si(2)-C(28), 1.929(7); Si(2)-Cl(2), 2.168(3); C(1)-Si(1)-Si(2), 98.76(19); Cl(1)-Si(1)-Si(2), 108.75(11); C(1)-Si(1)-Cl(1), 101.2(2); C(28)-Si(2)-Si(1), 98.7(2); Cl(2)-Si(2)-



Si(1), 107.96(11); and C(28)–Si(2)–Cl(2), 100.7(2). Selected bond distances (Å) and angles (deg) for (**3**) are Si(1)–Si(1A), 2.2294(11); Si(1)–C(1), 1.9271(15); and C(1)–Si(1)–Si(1A), 93.37(5).

with Si-Si-C angles approaching 90° (12). How might the fleeting diatomic Si₂ molecule be sufficiently stabilized for routine laboratory inquiry? We recently produced neutral diborenes, L:(H)B=B(H):L, by employing N-heterocyclic carbene ligands, L:, to complex the highly reactive and electron-deficient diborene(2) parent H-B=B-H (13, 14). Extending this strategy, we now report the syntheses (Fig. 1) (15), molecular structures (Fig. 2) (15), and computational analyses (16) of L:SiCl₄, 1; L:(Cl)Si-Si(Cl):L, 2, a carbene-stabilized bis-silylene; and L:Si=Si:L, 3, a carbene-stabilized :Si=Si: compound {where L: is :C[N(2,6-Pr $_{2}^{i}C_{6}H_{3})CH]_{2}$ and Pr i is isopropyl}. Both Si atoms in compound 3 are in the formal oxidation state of zero.

Kuhn et al. synthesized hypervalent L':SiCl₄ {where L': is $:C[N(R)C(CH_3)]_2$ and R is alkyl} complexes (17), which are neutral equivalents of [SiCl₅]⁻. Consistently, we found that roomtemperature reaction of a sterically demanding Nheterocyclic carbene ligand, L:, with SiCl₄ in hexane, gives L:SiCl₄, 1, in an essentially quantitative yield. The potassium graphite reduction of 1 (in a 1:KC8 ratio of 1:6) in hexane produced air-sensitive, orange-red, sheetlike crystals of 2 (6.1% yield) and air-sensitive, dark red, block crystals of 3 (as a minor product) (Fig. 1). However, when the potassium graphite reduction of 1 is performed (with a 1:KC₈ ratio of 1:4) in tetrahydrofuran (THF) (Fig. 1), compound 3 can be exclusively isolated and in higher yield (23.2%). In the ¹H nuclear magnetic resonance (NMR) spectra, the imidazole resonances (in C_6D_6) of compounds 1, 2, and 3 appear at 6.40, 6.31, and 6.58 parts per million (ppm), respectively. The ¹H-decoupled ²⁹Si NMR spectra of compounds 1 to 3 were also determined. The ²⁹Si NMR chemical shift of 1 (in CD₂Cl₂), -108.9 ppm, is comparable to reported values (-104.7 to -105.9 ppm) of hypervalent Si compounds L':SiCl₄ {where L': is :C[N(R)C(CH₃)]₂ and R

is alkyl} (17). The ²⁹Si NMR resonance of **2** (in C₆D₆), 38.4 ppm, compares with 78.3 ppm of $[C(H)N(tBu)]_2Si$: (18) and 14.6 ppm of $[PhC(NtBu)_2]SiCl (19)$, but is at a considerably lower field than the –48.6- to –57.4-ppm range of silylene-isocyanide complexes (20). The ²⁹Si chemical shift of **3** (in C₆D₆), 224.5 ppm, resides at an even lower field than typical disilene resonances (50 to 155 ppm) (5).

The x-ray structural analysis of 2 (Fig. 2) reveals that the (Cl)Si-Si(Cl) core is sterically wellshielded by the two L: ligands. The central Si-Si bond distance, 2.393(3) Å, is only about 0.05 Å longer than the sum of Si covalent radii (2.34 Å) (21) and about 0.03 Å longer than the Si-Si single-bond distance in α -silicon (2.36 Å) (22). Each Si atom in 2, in the formal +1 oxidation state, is three-coordinate in a trigonal pyramidal geometry. The sum of the bond angles of the Si atoms in 2, 308.0° (mean), compares very well with that in (tBu₂MeSi)₂Si(F)Li•(THF)₃ (307.6°) (23) as well as with the computed value for Ph2Si:CNPh (306.8°) (20). The pyramidal geometry at each Si atom in 2 results from substantial lone electronpair character on both Si atoms. The two L:(Cl)Si moieties of 2 adopt a gauche conformation [the Cl(1)-Si(1)-Si(2)-Cl(2) torsion angle is -46.5°]. These structural features of 2 are akin to those of its isolobal equivalent H₂P-PH₂, which also favors a gauche conformation (24). Although a Lewis base-stabilized silvlene was reported a decade ago (20), 2 is noteworthy as a Lewis basestabilized bis-silylene-namely, two silylene units bridged by a Si-Si bond. The Si-C bond distances [1.934(6) Å, mean] of **2** are comparable to that of 1 [1.928(2) Å] (fig. S1) whereas the mean Si-Cl bond distance [2.164(3) Å] of 2 matches the sum of the Si and Cl covalent radii (2.16 Å) (21). The visible absorption maximum of 2 ($\lambda_{max} = 510$ nm, in hexane) is similar to that of an intramolecularly base-stabilized three-coordinate silylene $(\lambda_{\rm max} = 478 \text{ nm}) (25).$

The nature of the bonding in 2 was delineated by density functional theory (DFT) computations at the B3LYP/6-311+G** level on the simplified L:(Cl)Si-Si(Cl):L [where L: is :C(NHCH)₂] model, 2-H. The computed Si-Si (2.405 Å) and Si-C (1.926 Å) bond distances of 2-H compare well with the experimental values [2.393(3) and 1.934(6) (mean) Å, respectively] of 2. The computed Si-Cl bond distance of 2.238 Å in 2-H is about 0.07 Å longer than that in 2 [2.164 (3) Å, mean]. The fact that the sum of the bond angles around the Si atoms in 2-H (298.2°) is smaller than that of $2 (308.0^\circ)$ may be attributed to the substantially lower steric crowding of the model ligands used in 2-H. The theoretical analysis of 2-H included both localized molecular orbitals (LMOs) (fig. S2) and canonical molecular orbitals (fig. S3). The LMOs reveal a Si-Si σ bonding orbital and two nonbonding lone-pair orbitals, one at each Si atom. Natural bonding orbital (NBO) analysis shows that the Si-Si σ single bond [Wiberg bond index (WBI) = 0.94] has 12.1% s-, 87.4% p-, and 0.5% d-character, whereas the nonbonding Si lone-pair orbitals have 68.3% s-, 31.6% p-, and 0.1% d-character. The Si-Cl bond has 8.5% s-, 89.9% p-, and 1.6% d-character.

We also examined the structure of the uncomplexed Si₂Cl₂ parent molecule. Unlike acetylenes and Sekiguchi's disilyne (*3*), a doubly-bridged (C_{2v}) Si(μ -Cl)₂Si geometry with a 102.1° dihedral angle between the two Si₂Cl rings is preferred in the B3LYP/6-311+G* (*16*) optimization, which compares with the doubly-bridged (C_{2v}) global minimum of Si₂H₂ (*26*). The Si–Si bond distance, 2.361 Å, corresponds to a single Si–Si bond. The symmetrical Cl-bridged bonding elongates the Cl–Si distance (2.387 Å) and involves Cl lone pairs. However, in **2** these Clbridging interactions are replaced by the complexation of two-electron donor carbene ligands to the Si atoms.



Fig. 3. The HOMO (π) , HOMO-1 (σ) , and HOMO-2 (lone pair) of **3-Ph**.

One structural feature of **3**, of C_i symmetry, is the :Si=Si: core (Fig. 2). The Si=Si bond distance in 3, 2.2294(11) Å, is within the reported range of disilene bond distances (2.14 to 2.29 Å) (5) and compares well with the computed [2.249 Å, BHLYP (27); 2.281 Å, B3LYP (16)] and experimental (2.246 Å) (28) bond distances of Si₂. Both OC:Si=Si:CO (2.310 Å, B3LYP) (12) and singlet $Si_2H_2^{2-}$ (2.288 Å, B3LYP) (29) suggest further comparisons. The Si-Si doublebond character of 3 is further supported by the $\pi_{Si=Si}\!-\!\!\pi^*_{Si=Si}$ absorption (λ_{max} = 466 nm, in THF), which is comparable to the reported ultraviolet/visible absorption maxima (390 to 480 nm) of stable disilenes (5). However, in contrast to previously reported disilenes, in which three-coordinate Si atoms (in the +2 formal oxidation state) reside in trigonal planar environments, the Si atoms in 3-in the formal oxidation state of zero-are only two-coordinate and have transbent geometries with C-Si-Si angles of 93.37(5)°. The two parallel carbene ligands are bound almost perpendicularly to the central Si=Si double bond. Generally, Si does not hybridize extensively. The almost-90° transbent skeletal conformation is consistent with the predominantly 3p-character of the Si-Si bonding orbitals in 3 and the predominantly 3s-character of the Si lone-pair molecular orbitals (see the NBO analysis below). Indeed, the nearly orthogonal transbent conformation of 3 is shared by the OC:Si=Si:CO complex, the dianionic Si₂H₂²⁻, and the simple valence isoelectronic HP=PH model of the dipnictene family, $R\ddot{E}=\ddot{E}R$ (E=P, As, Sb, Bi) (30), all of which possess an electron lone pair on the central core (E) atoms. The Si-C bonds [1.9271(15) Å] of **3** are only marginally shorter than those of 1 and 2. The fact that no ²⁹Si-¹H coupling was observed in the ¹H-coupled ²⁹Si NMR spectrum further supports the formulation of **3**.

DFT computations at the B3LYP/6-311+G** level on the simplified L:Si=Si:L {where L: is :C[N(C₆H₅)CH]₂} model, **3-Ph**, support the bonding analysis. The computed Si=Si bond distance (2.2407 Å), the Si–Si–C bond angle (99.2°), and the C–Si–Si–C torsion angle (180.0°) are very close to the experimental values of **3** [d_{Si=Si} = 2.2294(11) Å; Si–Si–C bond angle = 93.37(5)°, C–Si–Si–C torsion angle = 180.0°]. The highest occupied molecular orbital (HOMO) corresponds to the Si-Si π bond, whereas the HOMO-1 is dominated by the Si-Si σ bond. The HOMO-2 is one of the two nonbonding lone-pair molecular orbitals (Fig. 3).

The molecular orbital (MO) profile of **3-Ph** differs from that of the triplet $(X^3\Sigma_g^{-})$ ground state of the isolated Si₂ species, in which each of the two degenerate $1\pi_{\mu}$ MOs are occupied by one electron with the same spin (*31*). Complexation of Si₂ by two carbene ligands (as electron-pair donors) results in the occupancy of all valence orbitals of Si. Indeed, the WBI, 1.73, is supportive of a Si=Si double bond in **3-Ph**. NBO analysis characterizes the occupancies of the Si-Si σ bond as 17.3% s, 82.2% p, and 0.5% d, the Si-Si π bond as 0.0% s, 99.6% p, and 0.4% d, and the Si lone-pair nonbonding orbitals as 72.8% s, 27.2% p, and 0.0% d.

The B3LYP/6-311+G** computed (16) binding energies [zero point energy–corrected based on data in the supporting online material (SOM)] of the carbene ligand models {where L: is : $C[N(Me)CH]_2$ } to the Si-based cores are particularly noteworthy (Eqs. 1 to 3)

$$SiCl_4 + L: \rightarrow L:SiCl_4 (1-Me) - 10.6 \text{ kcal/mol}$$
(1)

 $\begin{array}{l} \text{Si}_2\text{Cl}_2 \left(\text{C}_{2\nu}\right) + 2\text{L:} \rightarrow \text{L:(Cl)Si-Si(Cl):L} \left(\textbf{2-Me}\right) \\ - 69.4 \text{ kcal/mol} \end{array}$

$$\begin{array}{c} \operatorname{Si}_{2}\left(X^{3}\Sigma_{g}^{-}\right)+2L: \rightarrow L: Si=Si:L \text{ (3-Me)}\\ -80.9 \text{ kcal/mol} \end{array} \tag{3}$$

The very large binding energies of **2-Me** and **3-Me** reflect the coordinatively unsaturated character of Si₂ ($X^{3}\Sigma_{g}^{-}$) and of Si₂Cl₂ (C_{2v}), respectively, as well as the remarkable complexation proclivity of the carbene ligand (*32*). Bulky N-heterocyclic carbene ligands are further demonstrated to be effective lone-pair donors capable of stabilizing—both thermodynamically and kinetically—unusual molecules.

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Supporting Online Material

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